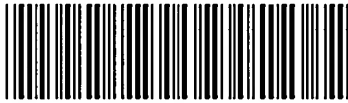


Search Notes



Application/Control No.

10/782,103

Examiner

Hwei-Siu C. Payer

Applicant(s)/Patent under Reexamination

WAISATH, CURT D.

Art Unit

3724

SEARCHED

| Class | Subclass | Date | Examiner |
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| 030 | 131 | up to late | Payer |
| | 179 | 10-12-05 | |
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| see Interference | | | |
| search History printout | | | |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
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| "PLUS" search conducted by STIC (see 10782103 LIST) | 10/12/05 | Payer |
| 83/13 tex search only | 10/13/05 | Payer |
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